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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

James W. Overbeck

Examiner: T.Q. Nguyen

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WIDE FIELD OF VIEW AND HIGH SPEED SCANNING MICROSCOPY

Commissioner for Patents
US Patent and Trademark Office

## REQUEST FOR TELEPHONE INTERVIEW

In addition to the Response filed herewith, the undersigned Applicant's representative respectfully asks Examiner Nguyen for a telephone interview, at the Examiner's convenience, to discuss any outstanding issue after considering the Response. Please call the undersigned representative at 781-274-6690 with the suggested time for the telephone interview.

Please apply any charges or credits to the Deposit Account No. 01-0431.

Respectfully submitted,

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The undersigned hereby certifies that this document is being placed in the United States mail with first-class postage attached, addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on

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Ivan D. Zitkovsky